

Bayesian Networks in Educational Testing

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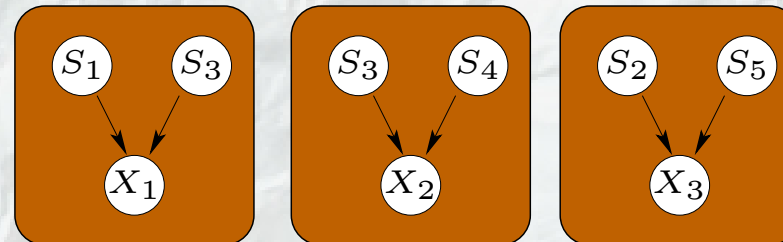
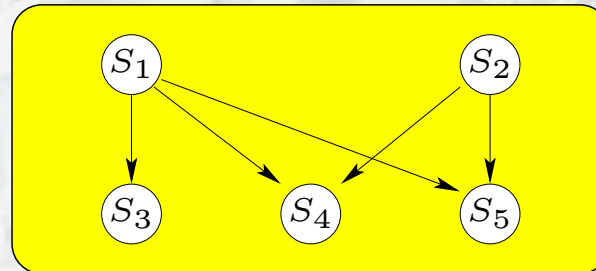
<http://www.utia.cas.cz/vomlel/slides/pgm02slides.pdf>

Contents:

- Student model and evidence models.
Knowledge about a student.
- Difference between a **fixed test** and an **adaptive test**.
- **Optimal** and **myopically optimal** tests.
- Construction of a **myopically optimal fixed test**.
- Test of **basic operations with fractions**.
- Results of **experiments**.

Student and evidence models

(R. Almond and R. Mislevy, 1999)

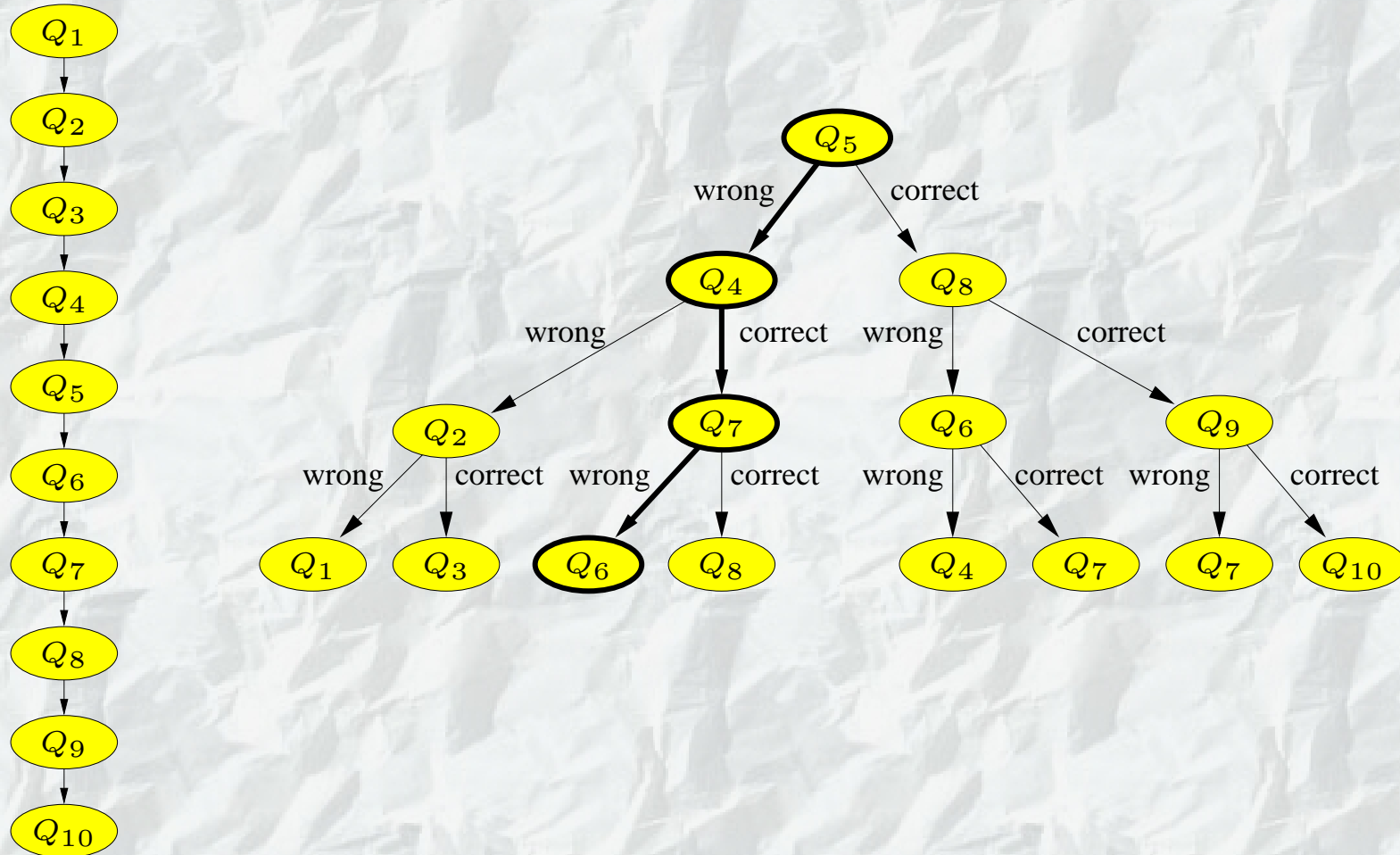


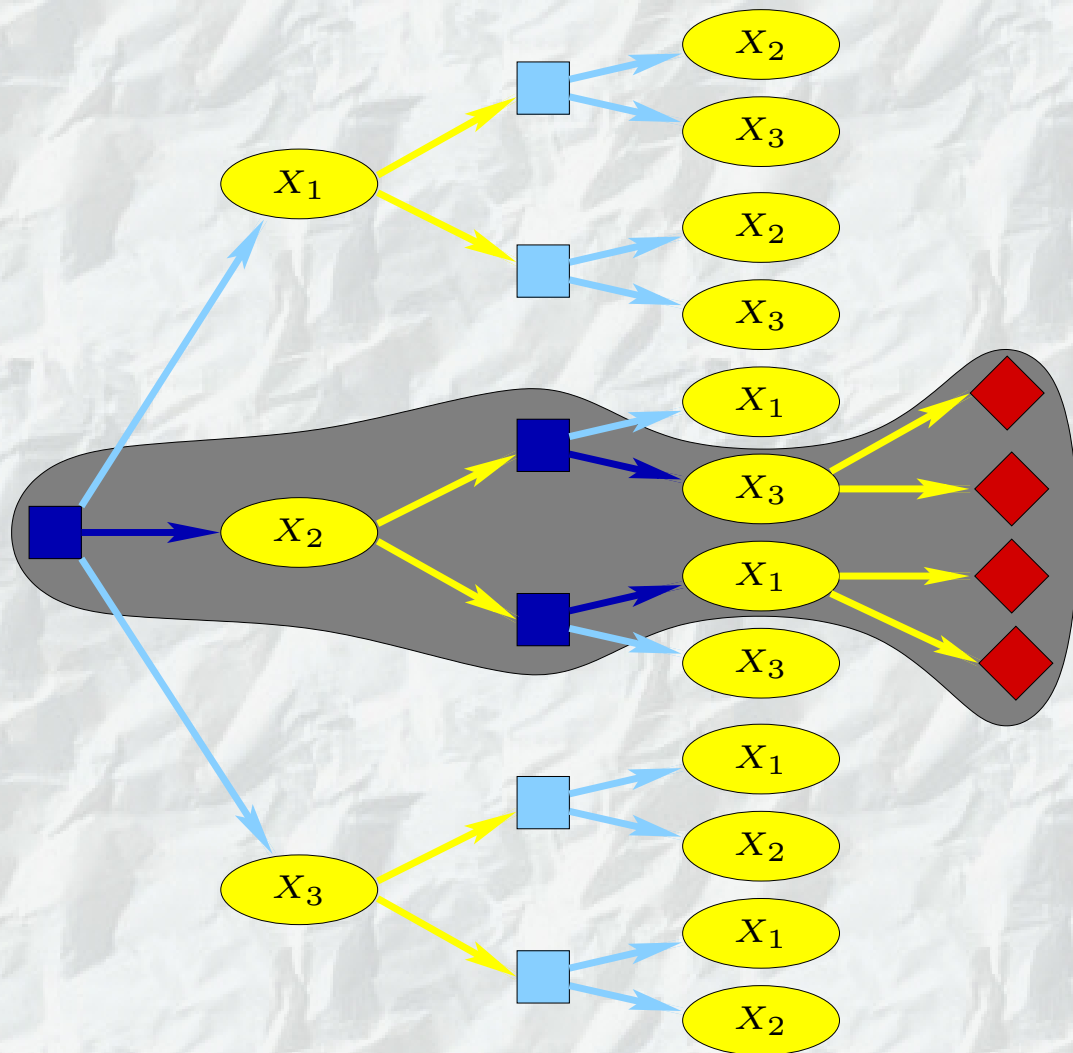
Entropy of probability distribution $P(\mathbf{S})$

$$H(P(\mathbf{S})) = - \sum_{\mathbf{s}} P(\mathbf{S} = \mathbf{s}) \cdot \log P(\mathbf{S} = \mathbf{s})$$

“The lower the entropy the more we know about a student.”

Fixed Test vs. Adaptive Test





Entropy in node n

$$H(\mathbf{e}_n) = H(P(\mathbf{S} \mid \mathbf{e}_n))$$

Expected entropy at the end of test \mathbf{t}

$$E_H(\mathbf{t}) = \sum_{\ell \in \mathcal{L}(\mathbf{t})} P(\mathbf{e}_\ell) \cdot H(\mathbf{e}_\ell)$$

\mathcal{T} ... the set of all possible tests
(e.g. of a given length)

A test \mathbf{t}^* is **optimal** iff

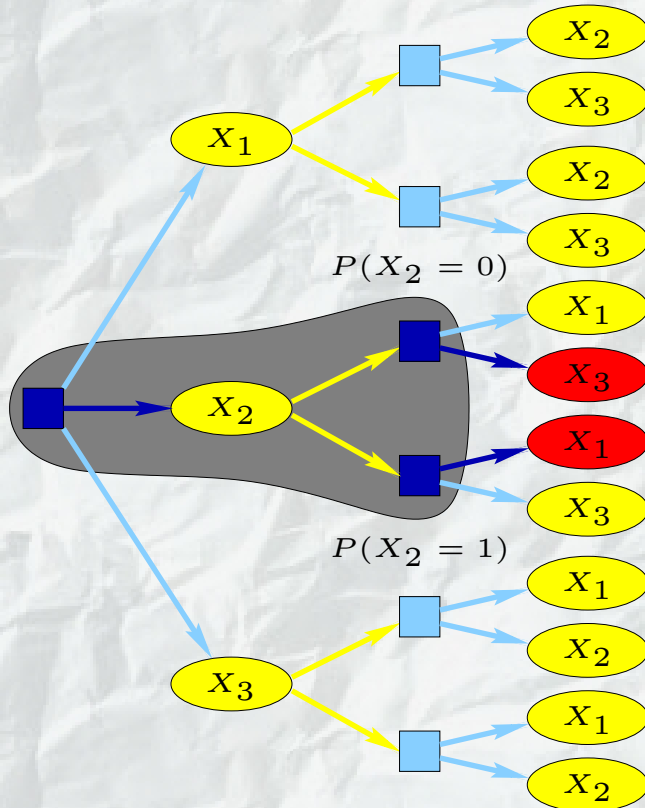
$$\mathbf{t}^* = \arg \min_{\mathbf{t} \in \mathcal{T}} E_H(\mathbf{t}) .$$

A **myopically optimal** test \mathbf{t} is a test where each question X^* of \mathbf{t} minimizes the expected value of entropy after the question is answered:

$$X^* = \arg \min_{X \in \mathcal{X}} E_H(\mathbf{t}_{\downarrow X}) ,$$

i.e. it works as if the test finished after the selected question X^* .

Myopic construction of a fixed test



$$e_list = \{\{X_2 = 0\}, \{X_2 = 1\}\}$$

$$counts[3] = P(X_2 = 0) = 0.7$$

$$counts[1] = P(X_2 = 1) = 0.3$$



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e_list := [∅];
test := [ ];
for i := 1 to |X| do counts[i] := 0;
for position := 1 to test_lenght do
  new_e_list := [ ];
  for all e ∈ e_list do
    i := most_informative_X(e);
    counts[i] := counts[i] + P(e);
    for all x_i ∈ X_i do
      append(new_e_list, {e ∪ {X_i = x_i}});
  e_list := new_e_list;
  i* := arg max_i counts[i];
  append(test, X_{i*});
  counts[i*] := 0;
return(test);

```

CAT for basic operations with fractions

Examples of tasks:

$$T_1: \left(\frac{3}{4} \cdot \frac{5}{6}\right) - \frac{1}{8} = \frac{15}{24} - \frac{1}{8} = \frac{5}{8} - \frac{1}{8} = \frac{4}{8} = \frac{1}{2}$$

$$T_2: \frac{1}{6} + \frac{1}{12} = \frac{2}{12} + \frac{1}{12} = \frac{3}{12} = \frac{1}{4}$$

$$T_3: \frac{1}{4} \cdot 1\frac{1}{2} = \frac{1}{4} \cdot \frac{3}{2} = \frac{3}{8}$$

$$T_4: \left(\frac{1}{2} \cdot \frac{1}{2}\right) \cdot \left(\frac{1}{3} + \frac{1}{3}\right) = \frac{1}{4} \cdot \frac{2}{3} = \frac{2}{12} = \frac{1}{6} \cdot$$

Elementary and operational skills

CP Comparison (common numerator or denominator) $\frac{1}{2} > \frac{1}{3}, \frac{2}{3} > \frac{1}{3}$

AD Addition (comm. denom.) $\frac{1}{7} + \frac{2}{7} = \frac{1+2}{7} = \frac{3}{7}$

SB Subtract. (comm. denom.) $\frac{2}{5} - \frac{1}{5} = \frac{2-1}{5} = \frac{1}{5}$

MT Multiplication $\frac{1}{2} \cdot \frac{3}{5} = \frac{3}{10}$

CD Common denominator $(\frac{1}{2}, \frac{2}{3}) = (\frac{3}{6}, \frac{4}{6})$

CL Cancelling out $\frac{4}{6} = \frac{2 \cdot 2}{2 \cdot 3} = \frac{2}{3}$

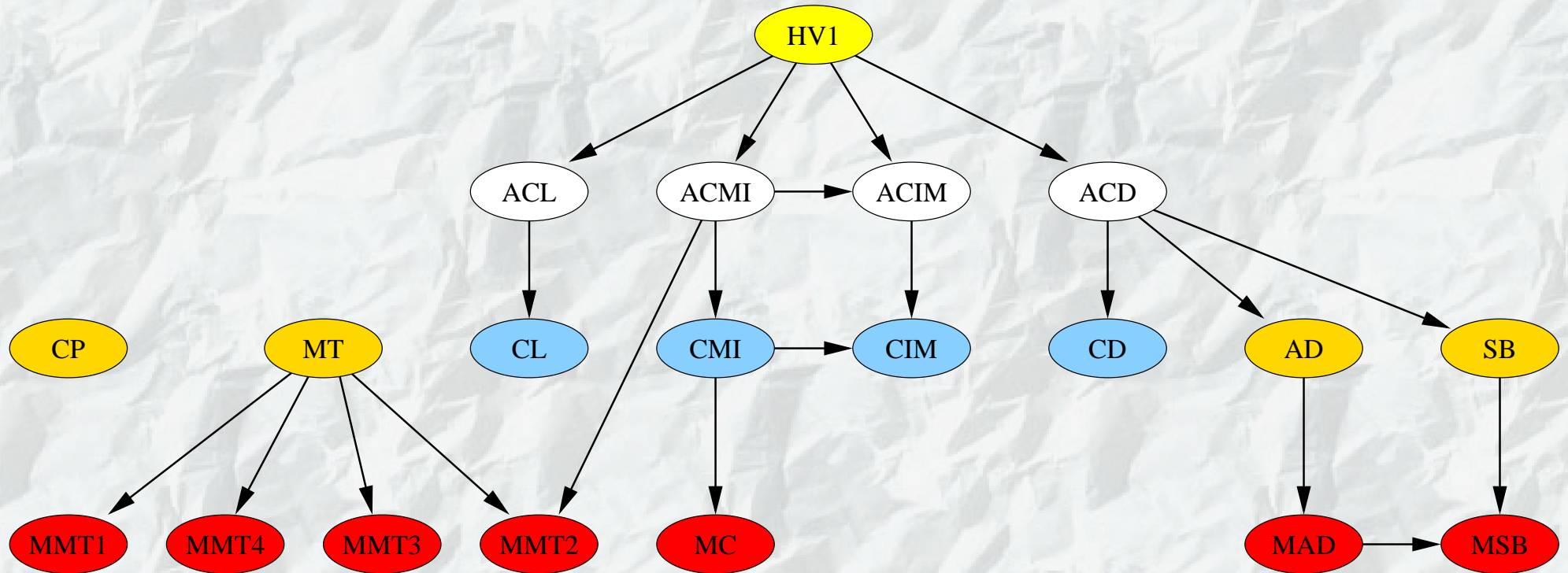
CIM Conv. to mixed numbers $\frac{7}{2} = \frac{3 \cdot 2 + 1}{2} = 3\frac{1}{2}$

CMI Conv. to improp. fractions $3\frac{1}{2} = \frac{3 \cdot 2 + 1}{2} = \frac{7}{2}$

Misconceptions

Label	Description	Occurrence
MAD	$\frac{a}{b} + \frac{c}{d} = \frac{a+c}{b+d}$	14.8%
MSB	$\frac{a}{b} - \frac{c}{d} = \frac{a-c}{b-d}$	9.4%
MMT1	$\frac{a}{b} \cdot \frac{c}{b} = \frac{a \cdot c}{b}$	14.1%
MMT2	$\frac{a}{b} \cdot \frac{c}{b} = \frac{a+c}{b \cdot b}$	8.1%
MMT3	$\frac{a}{b} \cdot \frac{c}{d} = \frac{a \cdot d}{b \cdot c}$	15.4%
MMT4	$\frac{a}{b} \cdot \frac{c}{d} = \frac{a \cdot c}{b+d}$	8.1%
MC	$a \frac{b}{c} = \frac{a \cdot b}{c}$	4.0%

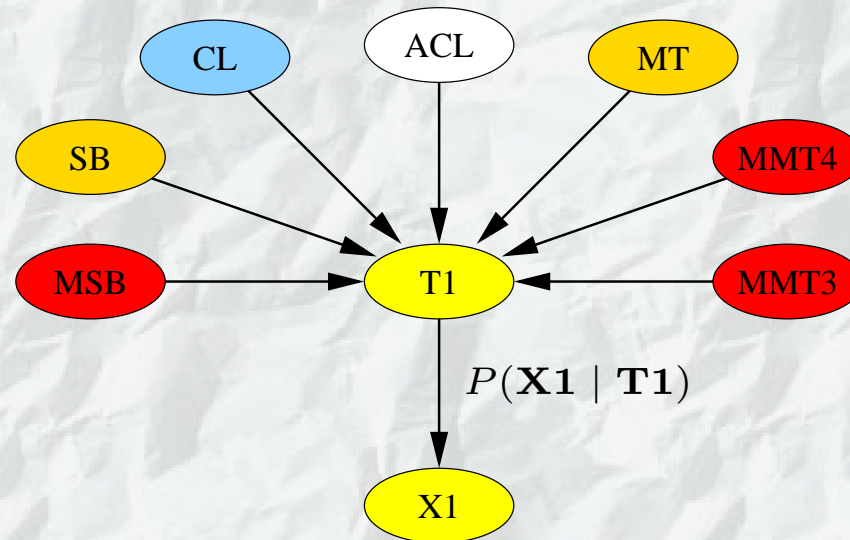
Student model



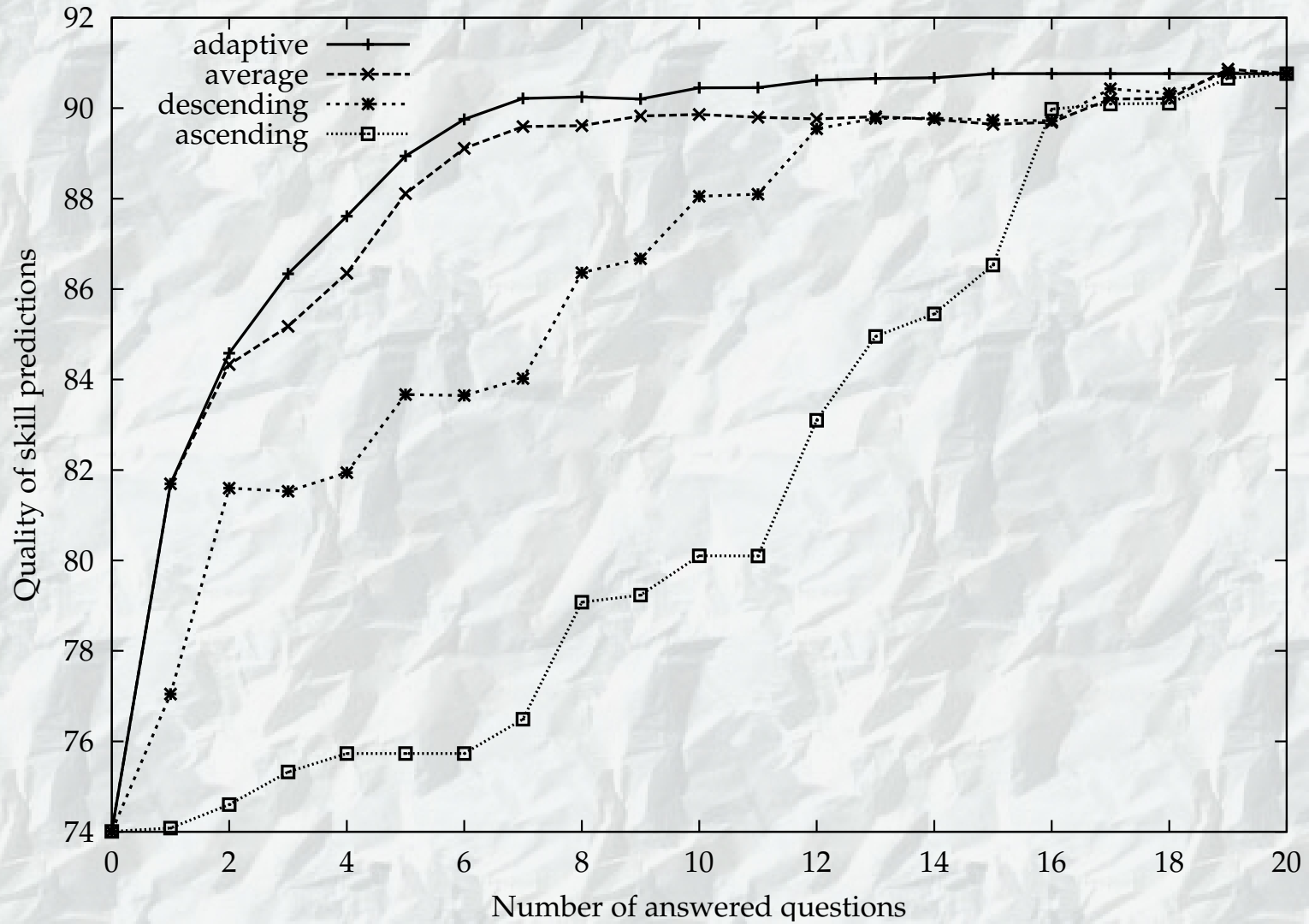
Evidence model for task $T1$

$$\left(\frac{3}{4} \cdot \frac{5}{6}\right) - \frac{1}{8} = \frac{15}{24} - \frac{1}{8} = \frac{5}{8} - \frac{1}{8} = \frac{4}{8} = \frac{1}{2}$$

$T1 \Leftrightarrow MT \& CL \& ACL \& SB \& \neg MMT3 \& \neg MMT4 \& \neg MSB$



Skill Prediction Quality



Conclusions

- Empirical evidence shows that educational testing can benefit from application of Bayesian networks. Adaptive tests may substantially **reduce the number of questions** that are necessary to be asked.
- **Method for** the design of a **fixed test** provided good results on tested data. It may be regarded as a good cheap alternative to computerized adaptive tests when they are not suitable.
- One theoretical problem related to application of Bayesian networks to educational testing is **efficient inference exploiting deterministic relations** in the model. This problem was topic of our UAI 2002 paper.